

10/533188

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Attorney's Docket No. 040857/291463

IN THE UNITED STATES DESIGNATED OFFICE (DO/US)

In re: Payman

Attn: DO/US

International Appl. No.: PCT/GB2003/004640

International Filing Date: October 27, 2003

For: A METHOD AND APPARATUS FOR TESTING FOR INTEGRATED CIRCUIT
CONTACT DEFECTS

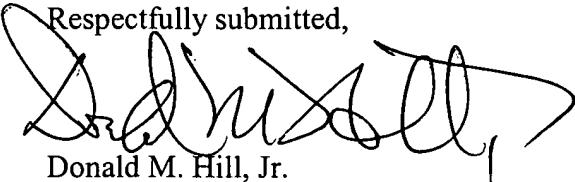
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INFORMATION DISCLOSURE STATEMENT

Sir:

The patents listed on the attached PTO-1449 were cited in the International Search Report of corresponding International Application No.PCT/GB2003/004640. A copy of the Search Report is enclosed for the Examiner's convenience. In accordance with the Office waiver published July 11, 2003, copies of the cited U.S. patents and patent application publications are not enclosed. Applicant does enclose copies of any cited foreign patent documents and non-patent literature in accordance with 37 CFR 1.98(a)(2).

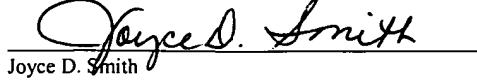
The Examiner may wish to consider the notations on the Search Report itself regarding the relevance of each item. It is requested that the Examiner consider these references and officially make them of record in accordance with the provisions of 37 C.F.R. § 1.97 and Section 609 of the MPEP. By submitting the listed documents, Applicant in no way makes any admission as to the prior art status of the listed documents, but is instead submitting the listed documents for the sake of full disclosure.

Respectfully submitted,


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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet	1	of	1	Attorney Docket Number	040857/291463
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Complete if Known

10/533188

Application Number

Filing Date Concurrently herewith

First Named Inventor

Payman

Group Art Unit

Examiner Name

U. S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number Number - Kind Code (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages of Relevant Figures Appear
	1	US-4,779,041	10-18-1988	Williamson, Jr.	
	2	US-5,280,237	01-18-1994	Buks	
	3	US-5,365,180	11-15-1994	Edelman	
	4	US-5,554,928	09-10-1996	Stringer	
	5	US-5,521,513	05-28-1996	Stringer	
	6	US-5,736,862	04-07-1998	Hamblin	
	7	US-5,786,700	07-28-1998	Jen et al.	
	8	US-6,188,235	02-13-2001	Buks et al.	

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Foreign Patent Document Country Code - Number Kind Code (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	English Language Translation Attached
	9	EP 0 571 963 A2	12-01-1993	SPEA S.r.l. Sistemi et al.		
	10	EP 0 622 733 A1	11-02-1994	SGS-Thomson Microelectronics s.r.l.		

OTHER DOCUMENTS

Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	English Language Translation Attached
	11	Analog AC Harmonic Method for Detecting Solder Opens, C. Robinson, IEEE Proceedings of the International Test conference, 1997	
	12	Nonlinear Distortion Voltage Testing of Contact Surfaces, I. Minowa et al., Conference Proceedings Article, September 26, 1988, pp. 277-280	

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*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. #4708773v1